

Application/Control No.

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Maikhanh Nguyen

ROSSMANN ET AL.

Applicant(s)/Patent under Reexamination

Art Unit

	SEARCHED				
Class	Subclass	Date	Examiner		
715	500	1/24/2007	MK		
715	513 517	1/24/2007	MK		
715	526 530	1/24/2007	МК		
709	203 207	1/24/2007	MK		
709	217 219	1/24/2007	МК		
455	414.3 422.	1/24/2007	мк		
455	419	1/24/2007	MK		
Updated	above	8/2/2007	мк		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor Name Search	1/24/2007	МК		
West Search (USPAT, USPGPub, EPO, JPO, DERWENT) See Search History	1/24/2007	мк		
NPL (IEEE) See Search History Printout	1/24/2007	МК		
West Search (USPAT, USPGPub, EPO, JPO, DERWENT) See Search History	8/2/2007	мк		